

R&D of microchannel plate PMT for DIRC detectors of PANDA.

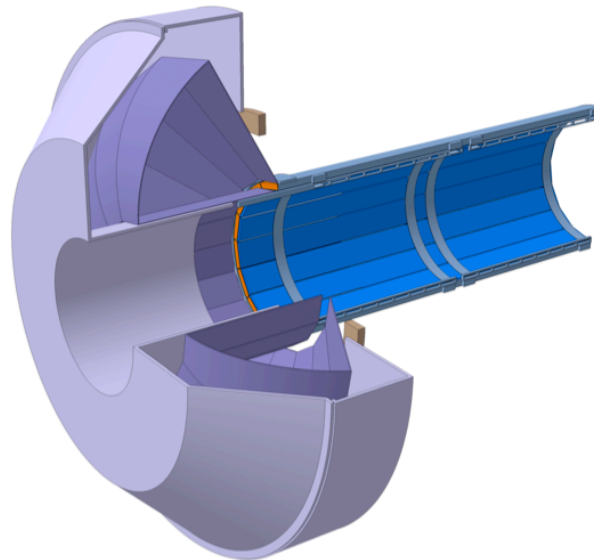
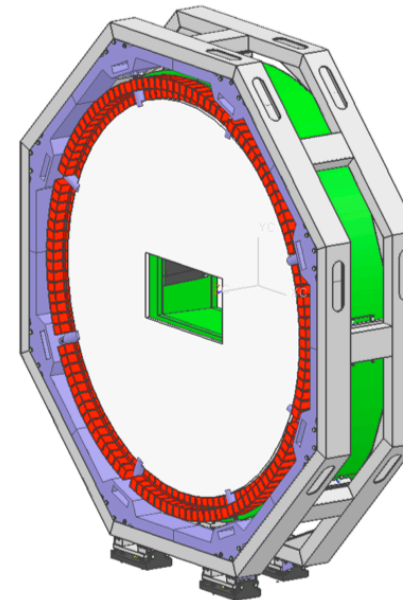
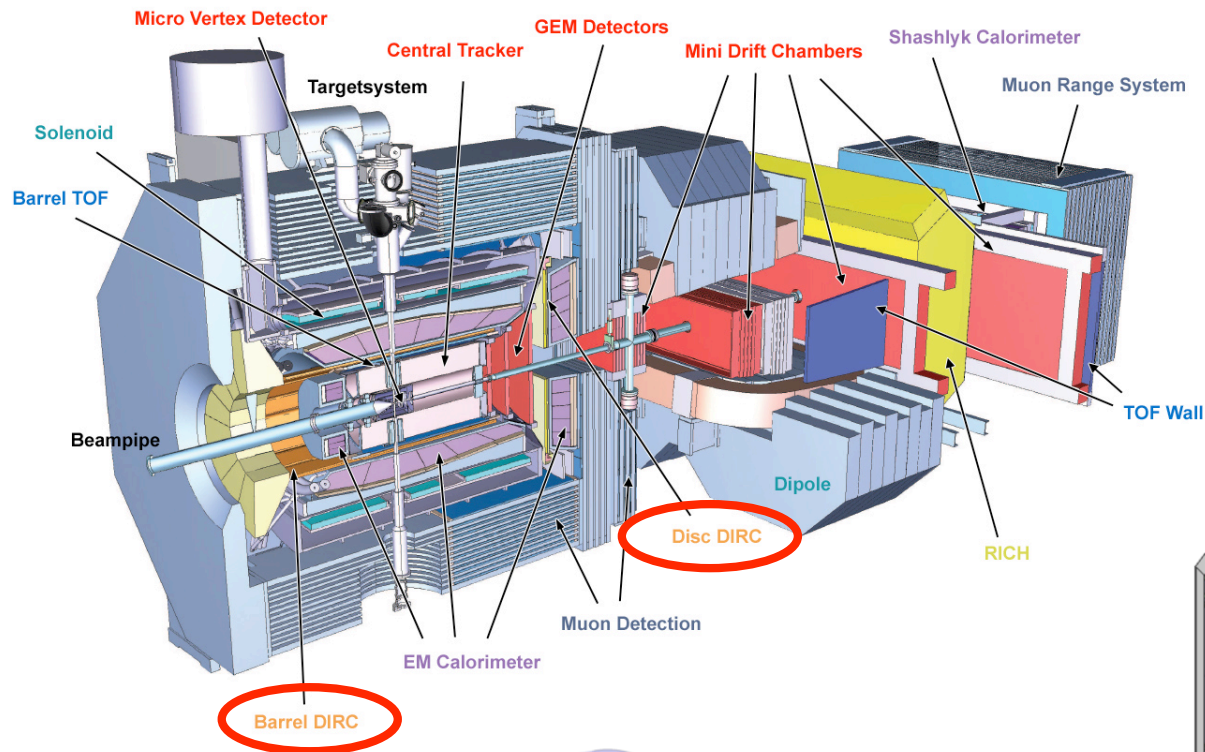
M. Yu. Barnyakov

Budker Institute of Nuclear Physics, Novosibirsk, Russia

Outline:

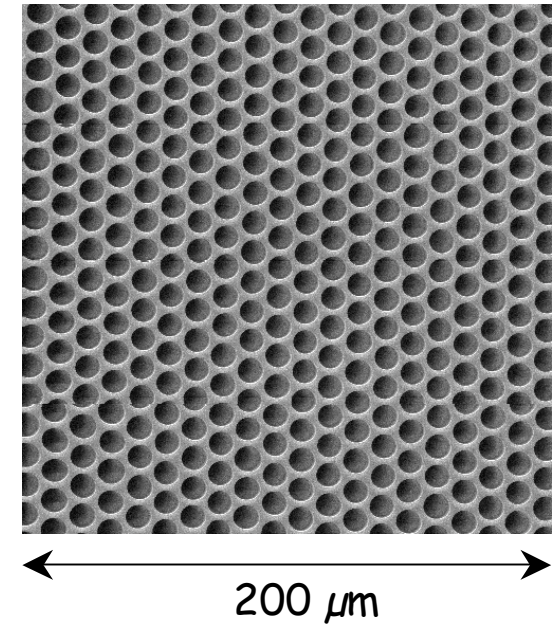
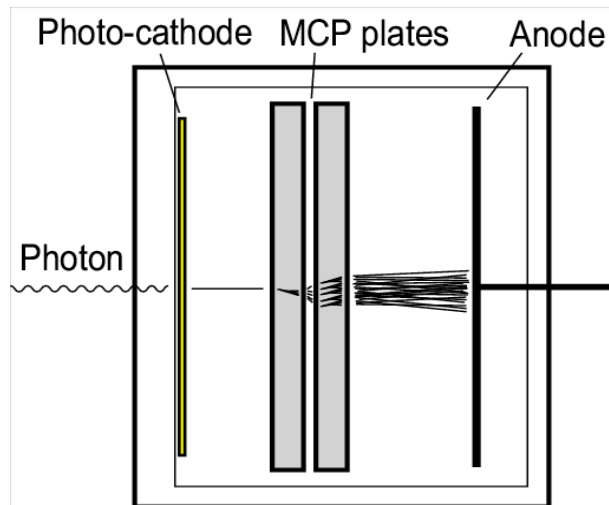
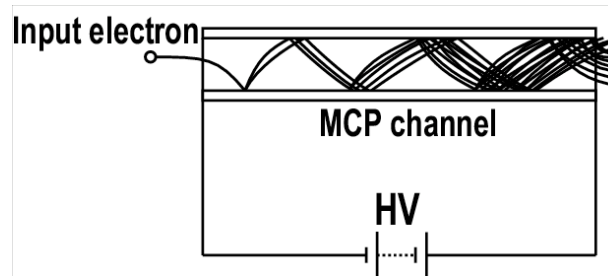
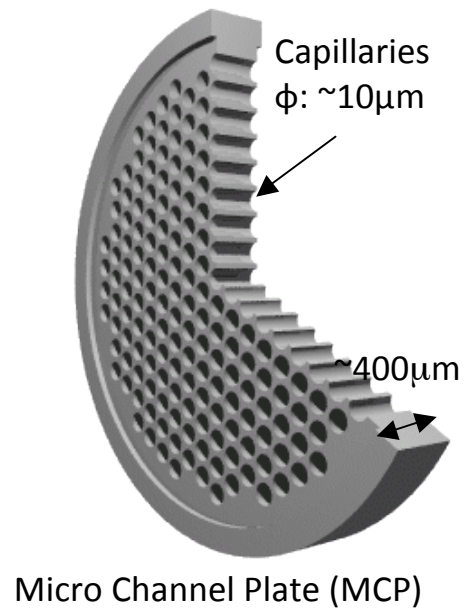
- MCP PMT for PANDA
- Counting rate capability
- Photocathode aging
- Lifetime of the best sample
- Conclusions

DIRCs of PANDA



Single photon detection
Magnetic field ~ 1 T
Space resolution ~ 1 mm
Time resolution ~ 100 ps

Microchannel plate PMT



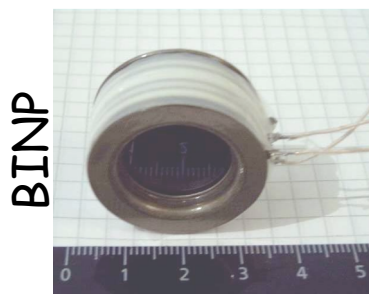
MCP PMT in HEP experiments (present & future)

<i>Experiment</i>	<i>System</i>	<i># PMTs</i>	<i>B-Field</i>	<i>Gain</i>	<i>Rate, $s^{-1}cm^{-2}$</i>	<i>I_{ANODE}, $C/cm^2/year$</i>
KEDR	ASHIPH	160(80)	$\leq 1.5T$	$3 \cdot 10^5$	$\sim 10^4$	< 0.03
SND	ASHIPH	9	0 T	$5 \cdot 10^5$	$\sim 10^4$	< 0.05
CMD-3	TOF	32	$\sim 0.02 T$	$\sim 10^6$	$\sim 10^4$	< 0.10
Belle II	TOP	256	1.5 T	10^6	10^5	0.16
PANDA	Disk DIRC	250	$\sim 1 T$	10^6	$\sim 10^6$	~ 5
PANDA	Barrel DIRC	256	$\sim 1 T$	10^6	$\leq 2 \cdot 10^5$	≤ 1
LHCb	TORCH	198	0 T	?	?	~ 5

BINP

Hamamatsu
SL10

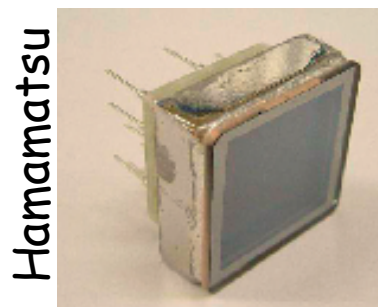
Burle/Photonis
Planacon



BINP

Ø 18mm

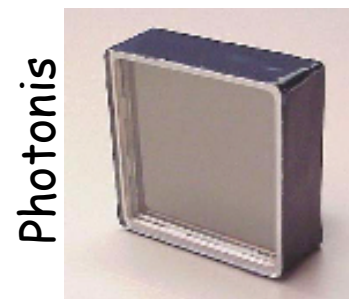
M.Yu.Barnyakov



Hamamatsu

2x2 cm

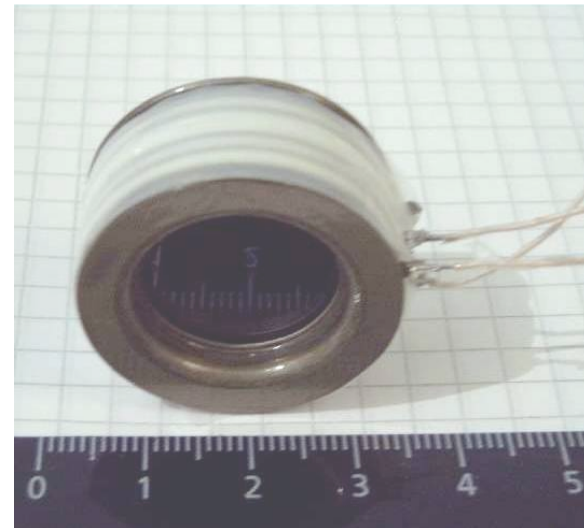
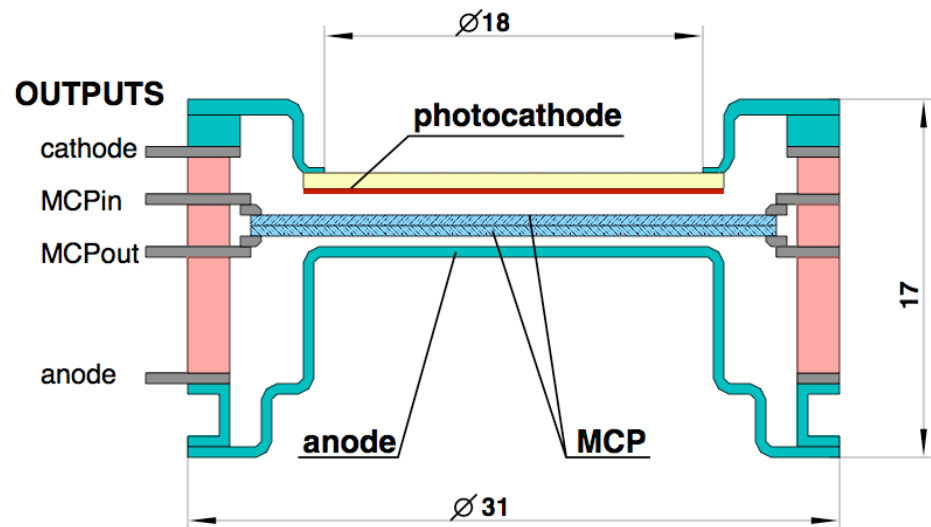
FRRC seminar, 22.06.11



Photonis

5x5 cm

MCP PMT under investigation



Manufacturer: "Ekran FEP" (Novosibirsk)

Borosilicate glass window

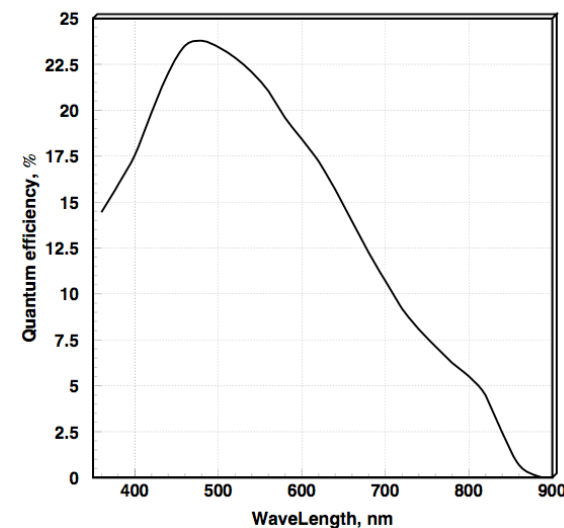
Multialkali (Sb-Na-K-Cs) photocathode

Maximum QE at $\lambda=500\text{nm}$

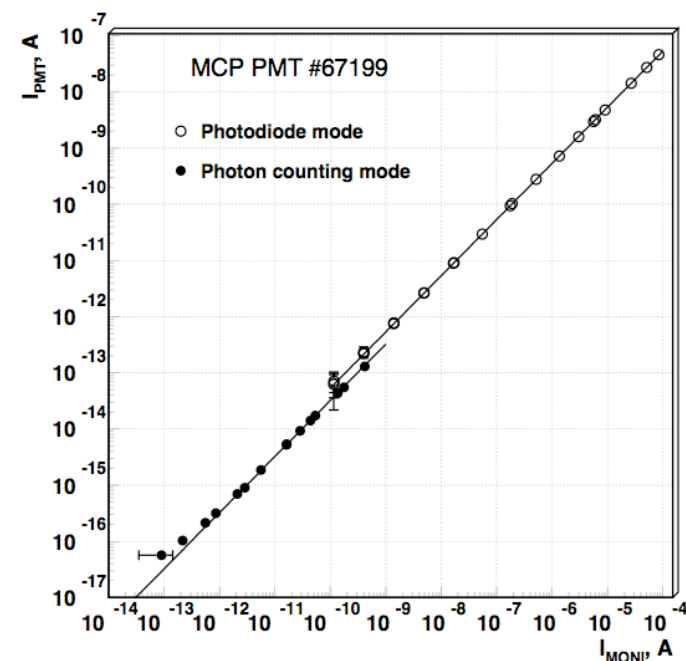
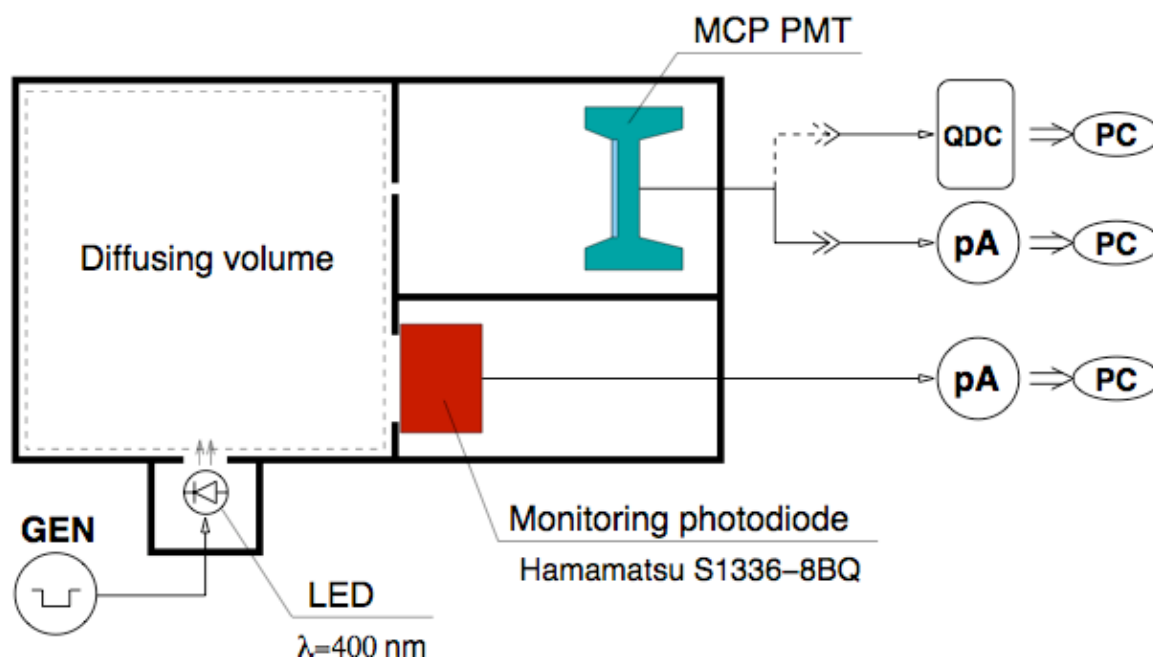
Two MCPs with channel diameter of $7 \mu\text{m}$

Channel bias angle 13°

Single anode



Experimental setup

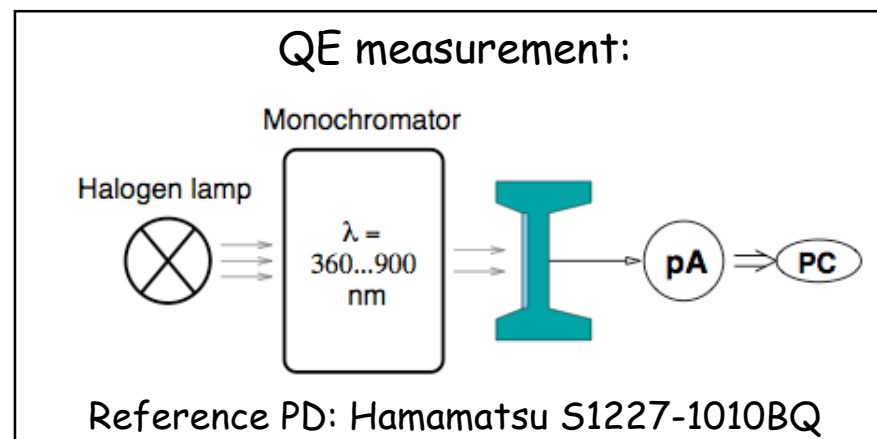


Low light intensity (photon counting mode):

$$K = R_{\text{PMT}} / I_{\text{MONI}}$$

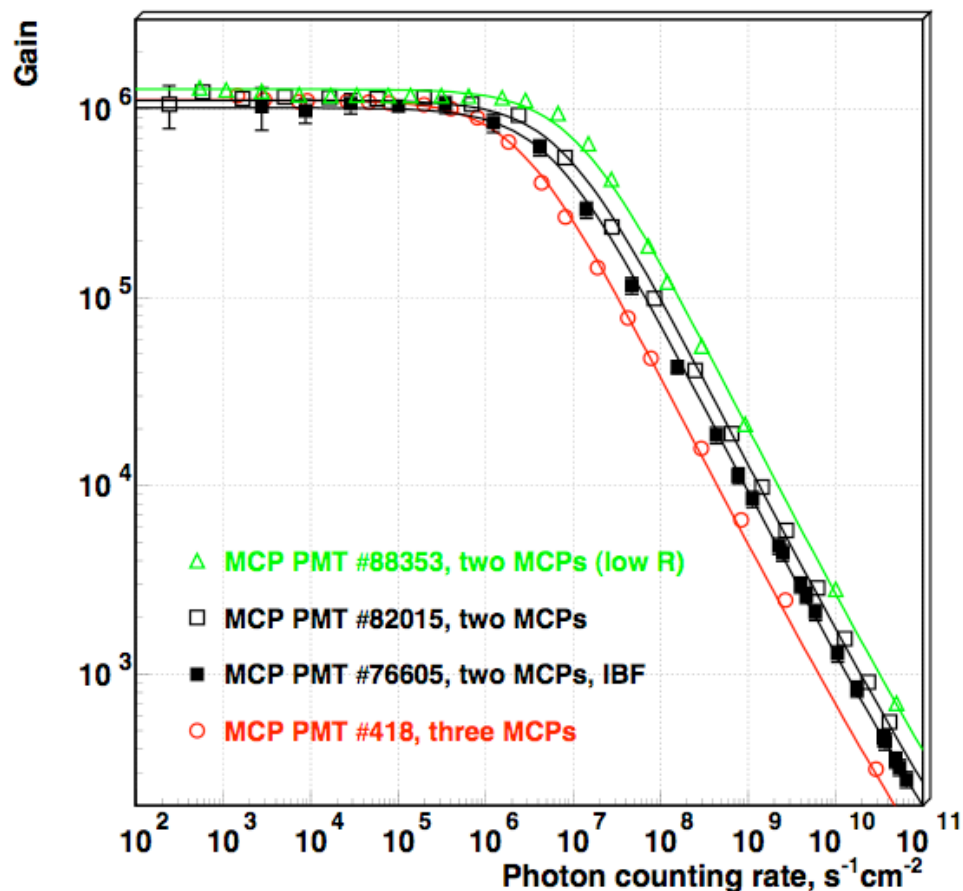
High light intensity (direct current mode):

$$R_{\text{PMT}} = I_{\text{MONI}} K$$



Gain decrease at high counting rate

A.B.Berkin and V.V.Vasilyev,
Technical Physics, 2008, Vol. 53, No. 2, p.272



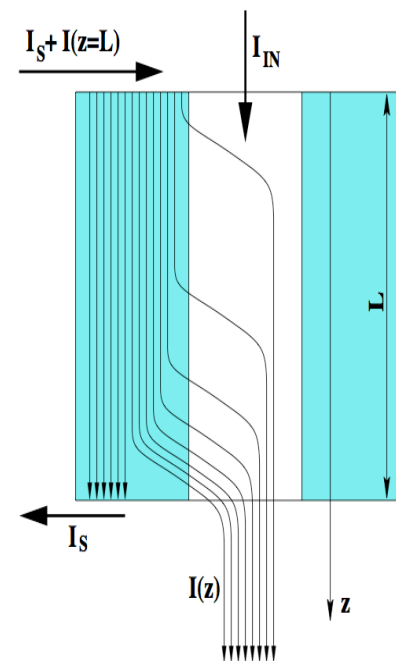
$$G = G_0 \cdot \ln(G_0) / F / (1 + I_{in}/I_s \cdot e^{\alpha z})$$

$$I(z) = I_{in} e^{\alpha z} \ln(G_0) / F / (1 + I_{in}/I_s \cdot e^{\alpha z})$$

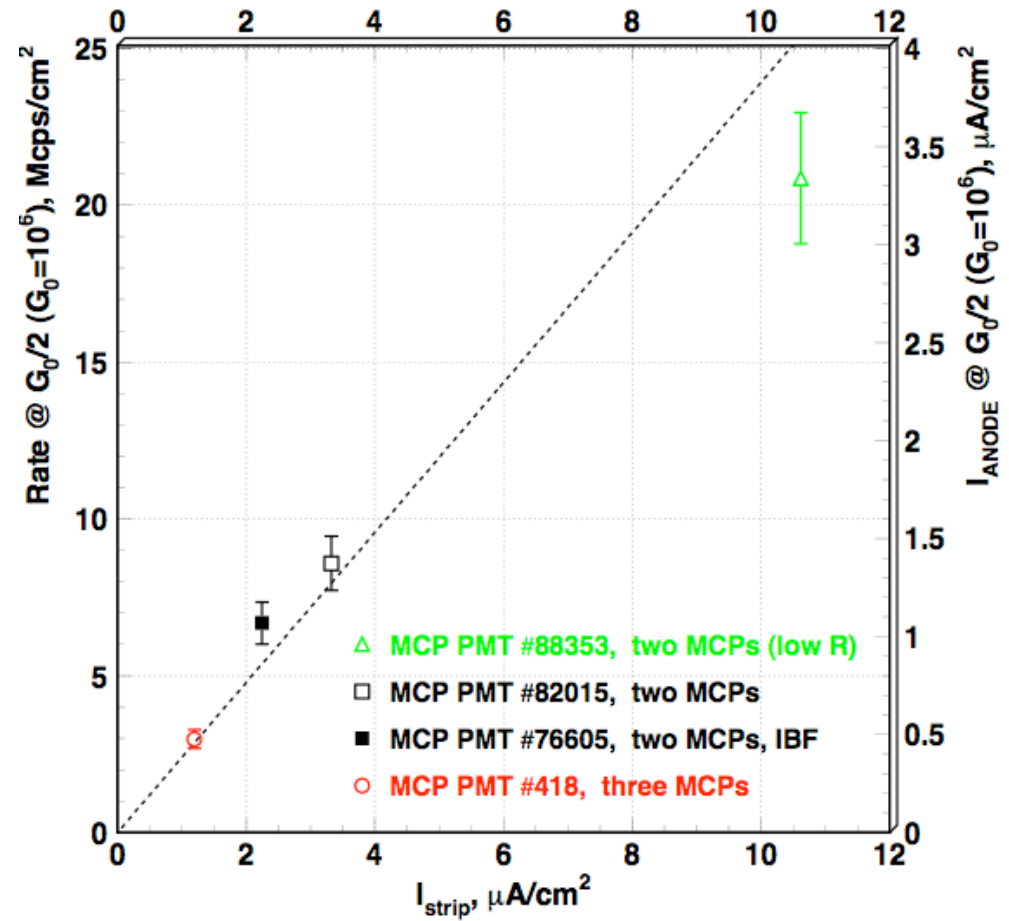
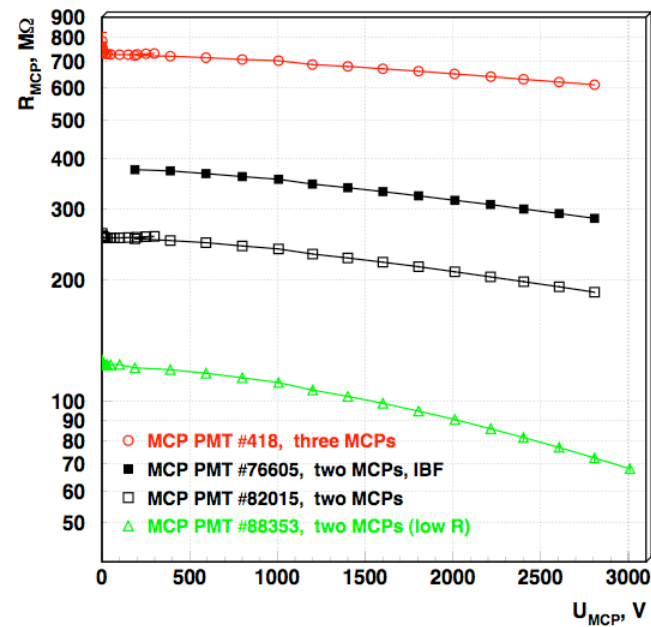
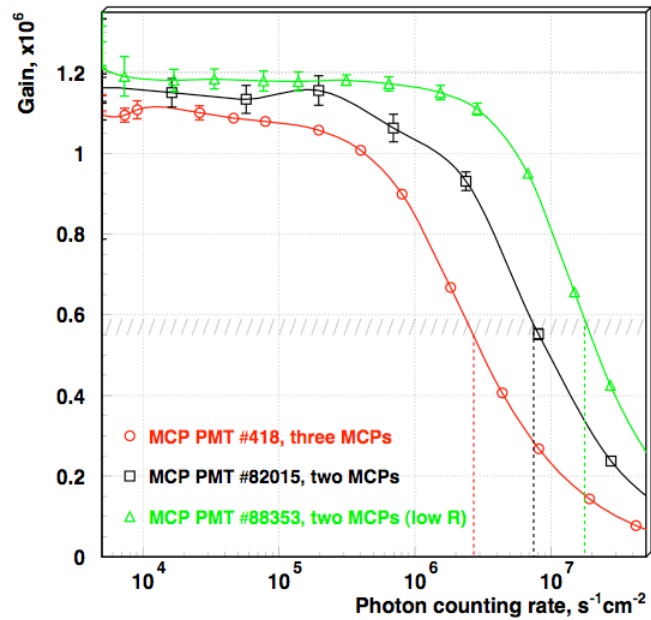
where

$$F = \ln(G_0) + \ln(1 + I_{in}/I_s) - \ln(1 + I_{in}/I_s \cdot G_0)$$

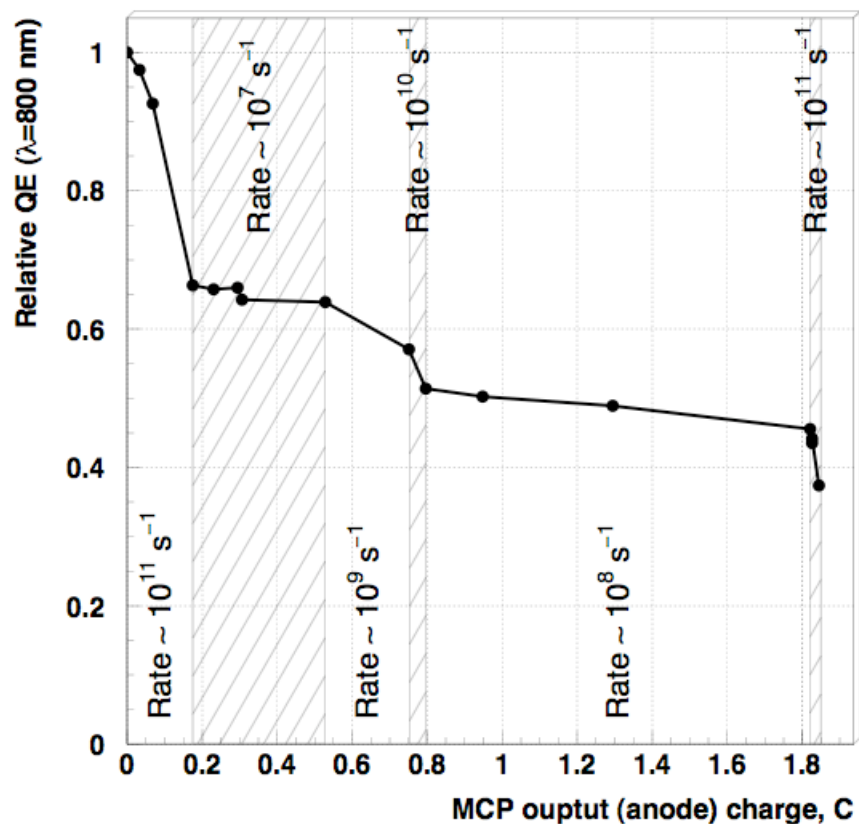
$$\alpha = \ln(G_0)/L$$



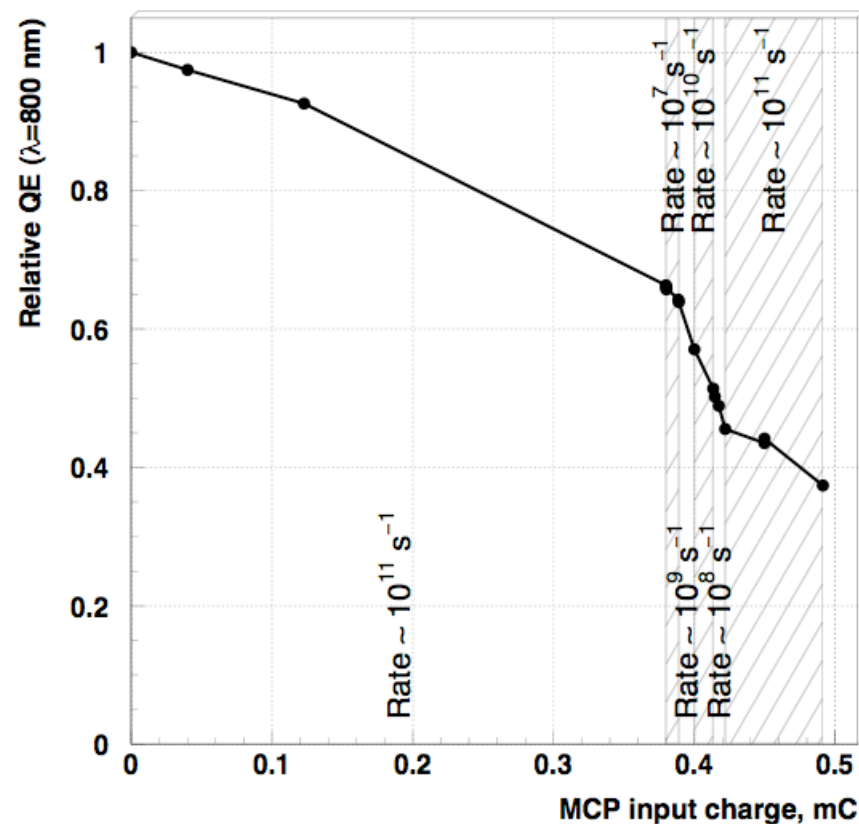
Rate capability vs. strip current



QE degradation at different counting rates



The higher counting rate the faster QE degradation per unit of anode charge



The higher counting rate the slower QE degradation per unit of cathode charge

Calculation of 1st MCP current

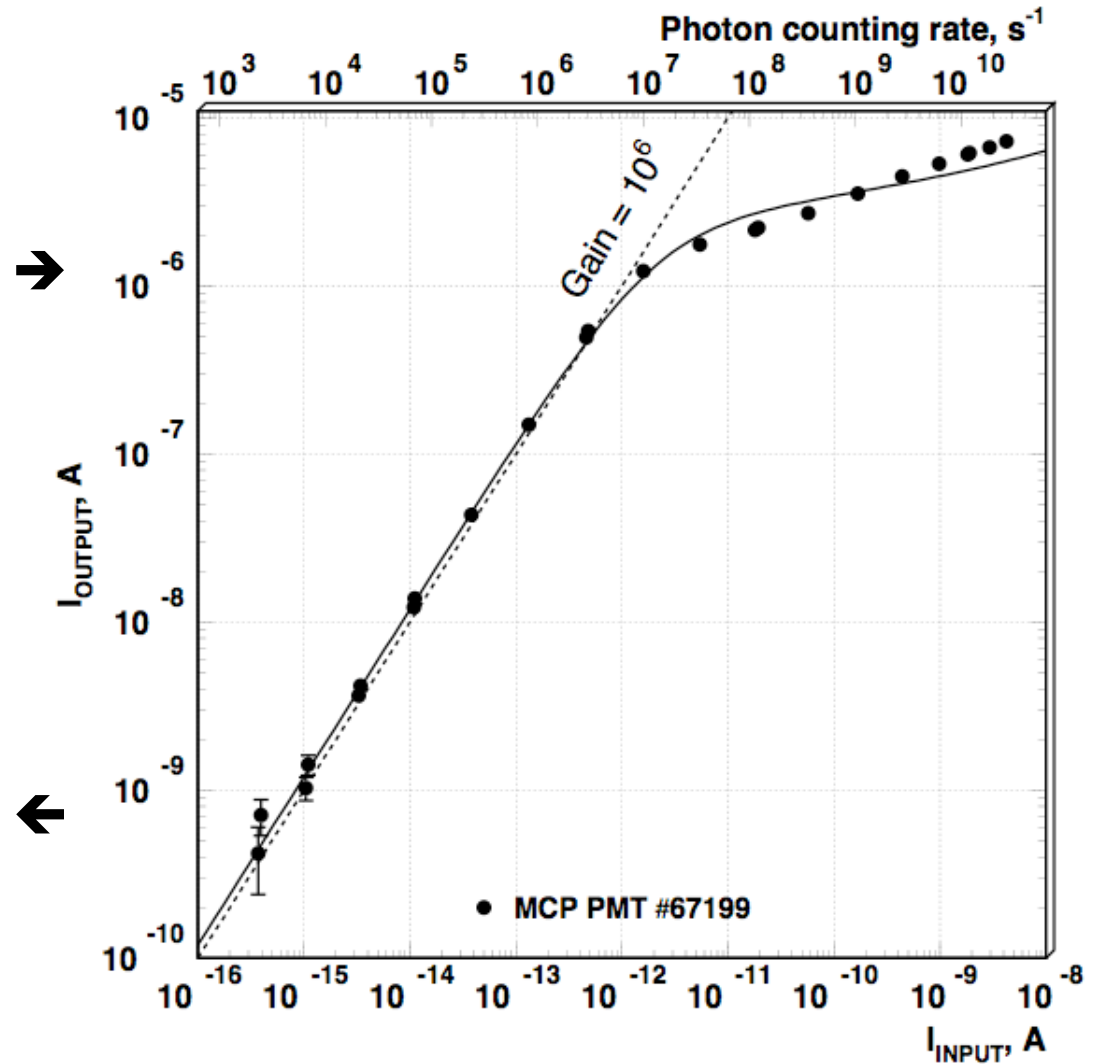
Approximation of dependence

$I_{\text{OUTPUT}}(I_{\text{INPUT}})$:

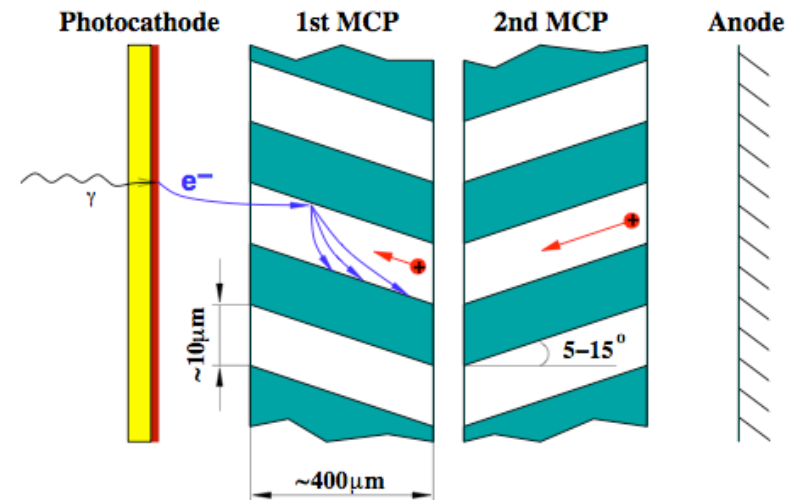
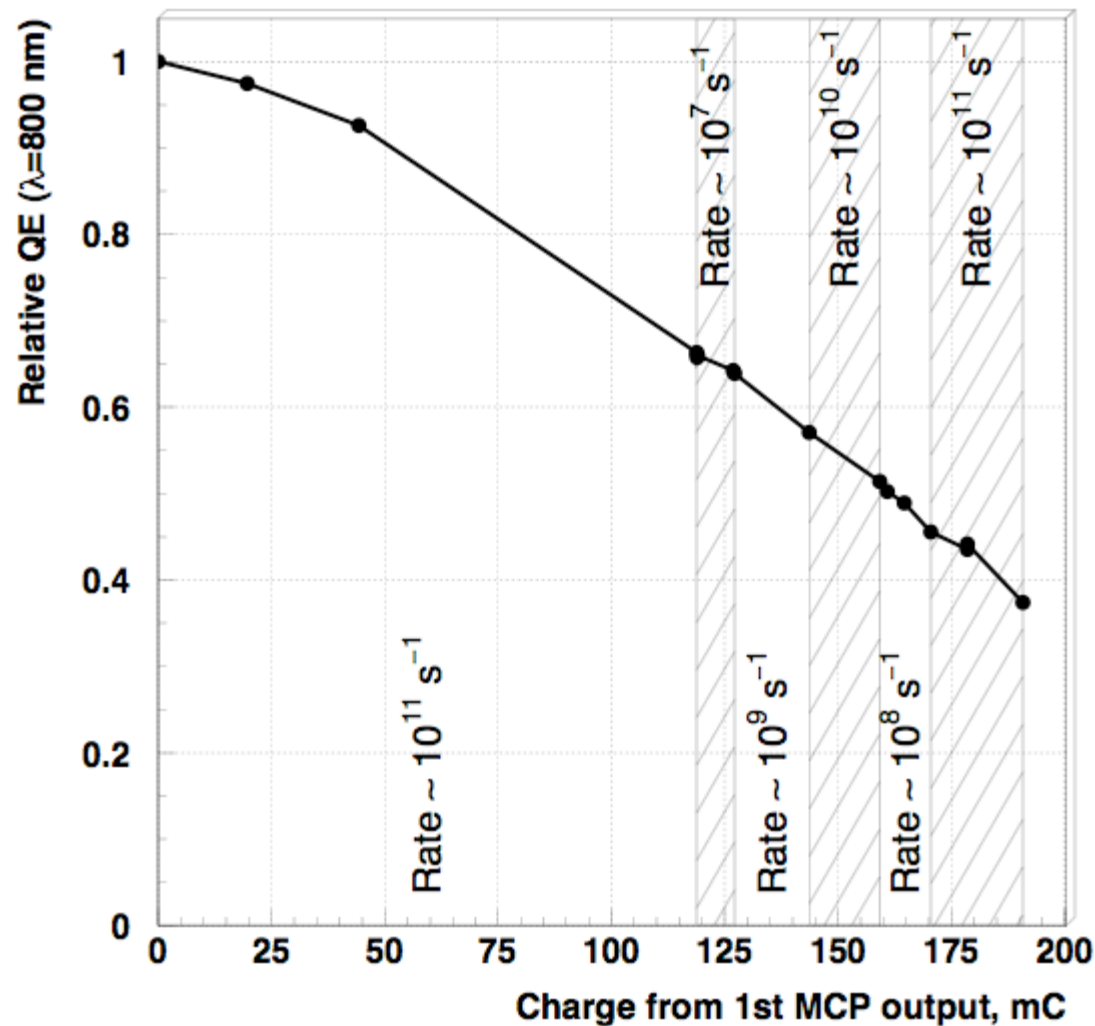
$I(z=L) = f(I_{\text{in}}, G_0, I_s)$
 G_0 and I_s - free parameters

Calculation of the current
extracted from 1st MCP:

$I(z=L/2)$ using G_0 and I_s
obtained from approximation



QE degradation vs. charge from 1st MCP



Correlation between QE degradation rate and photon counting rate is not observed !

Use of the result:

- Correct comparison of the aging of different samples of PMT.
- Lifetime improvement by redistribution of gain between 1st and 2nd MCP.

Enhancement of MCP degassing: gain

Two stage of MCP degassing:

1. Heating
2. Electron scrubbing

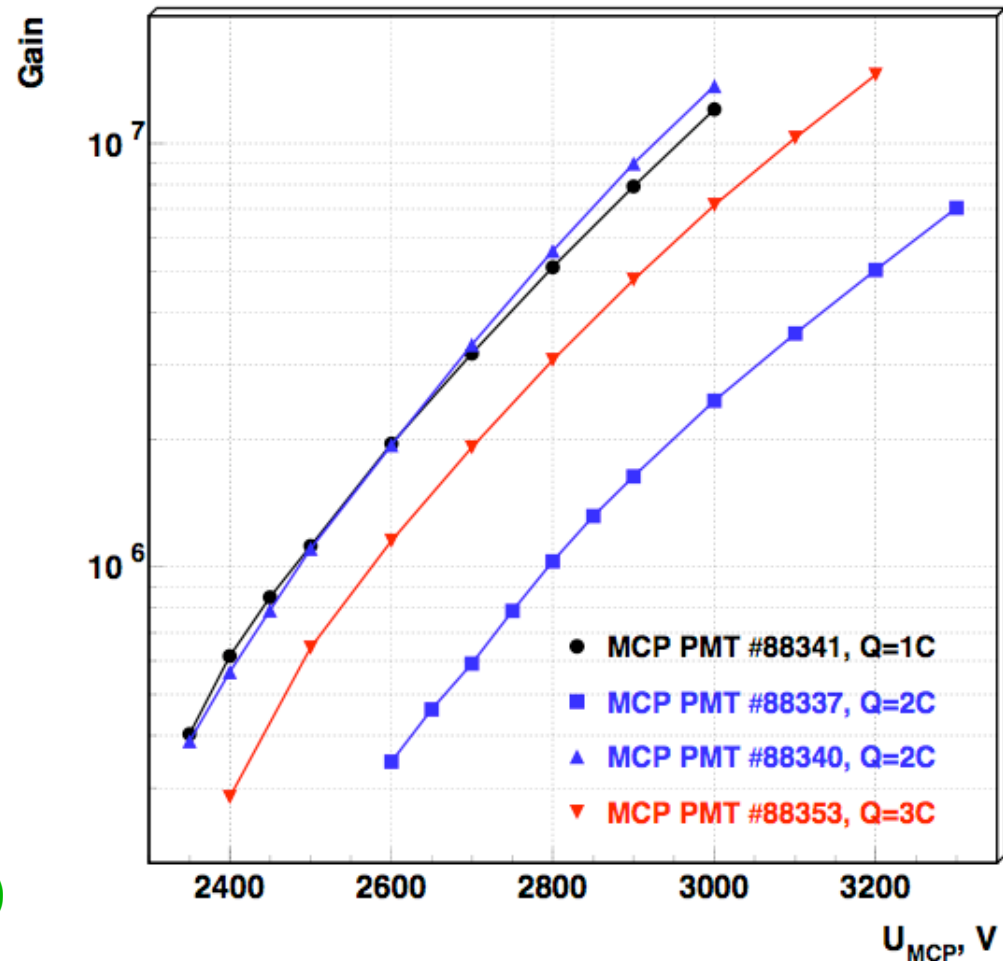
+ Photocathode lifetime increase

- Gain degradation

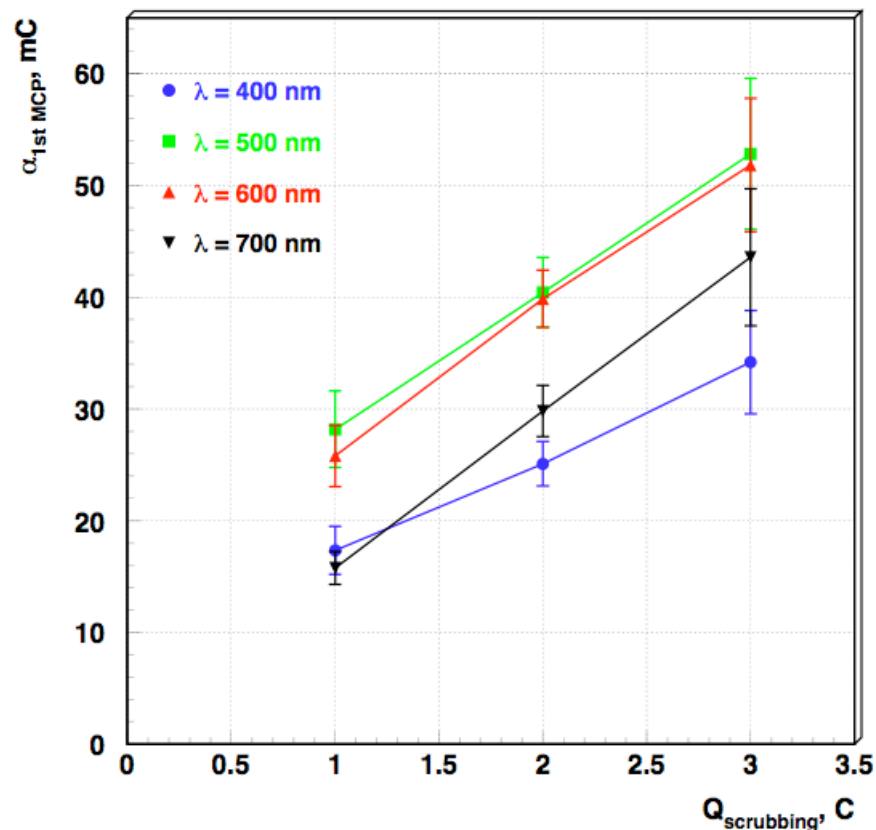
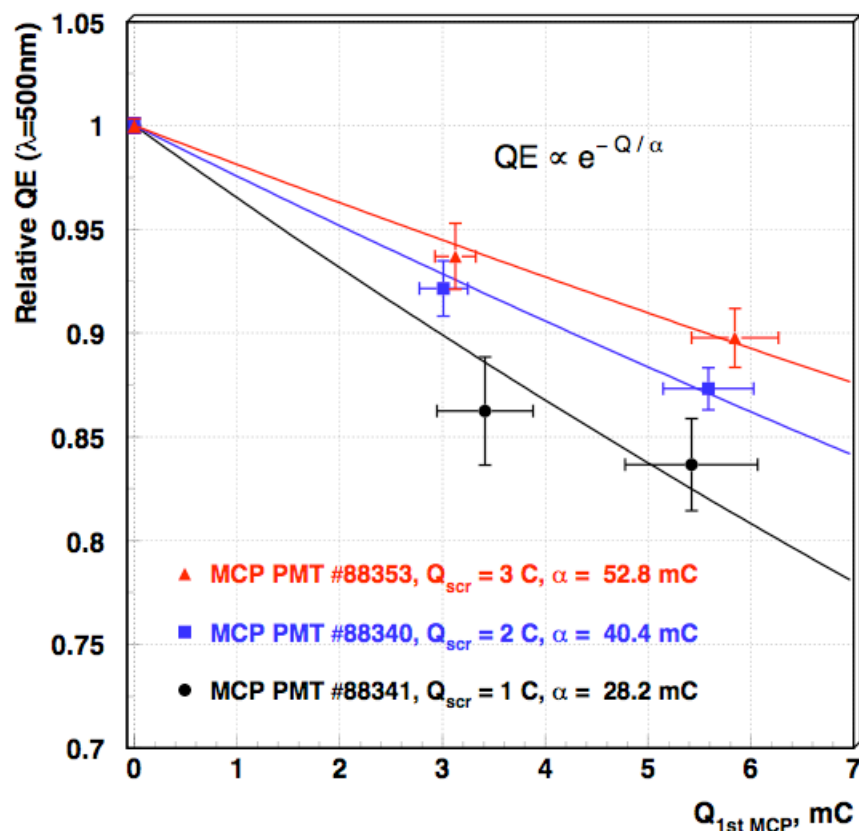
Duration of electron scrubbing has been increased in 2 and 3 times



MCP gain is not affected
(large spread of initial MCP quality)

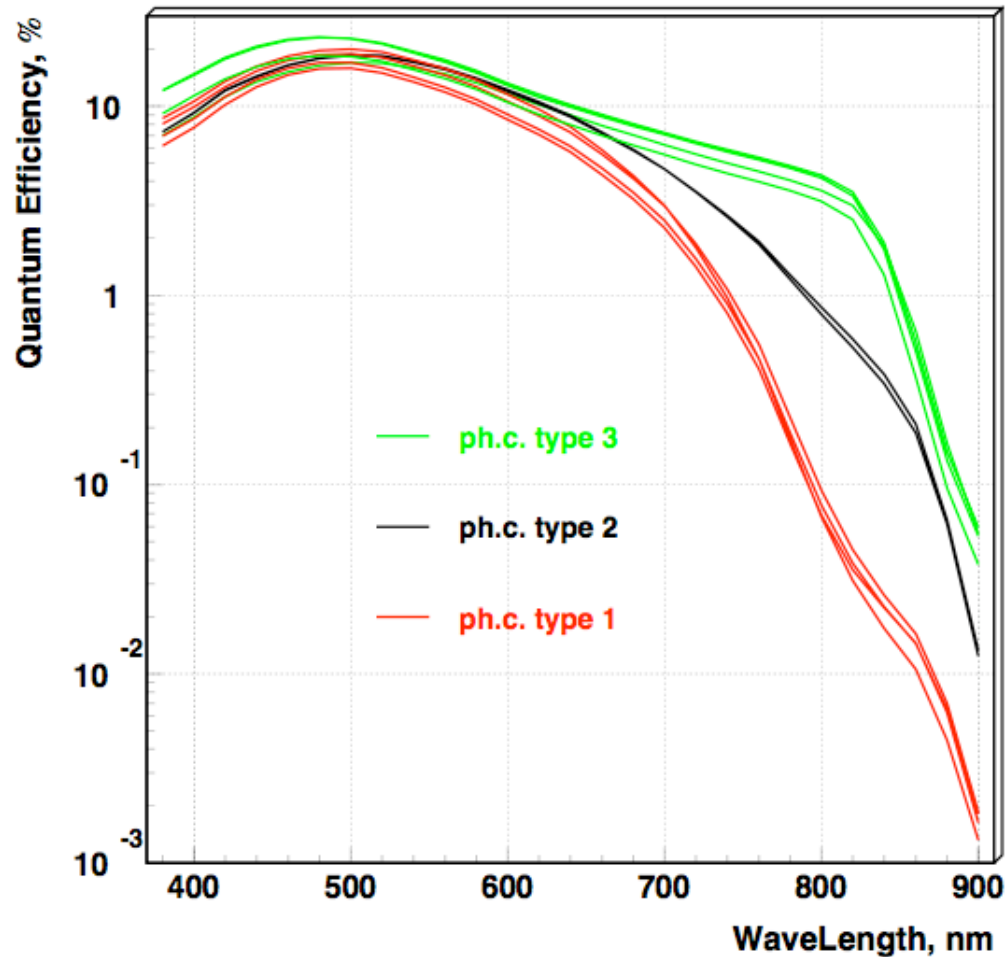


Enhancement of MCP degassing: aging



Three times better electron scrubbing
 ↓
 Two times slower QE degradation

Photocathodes: spectral response

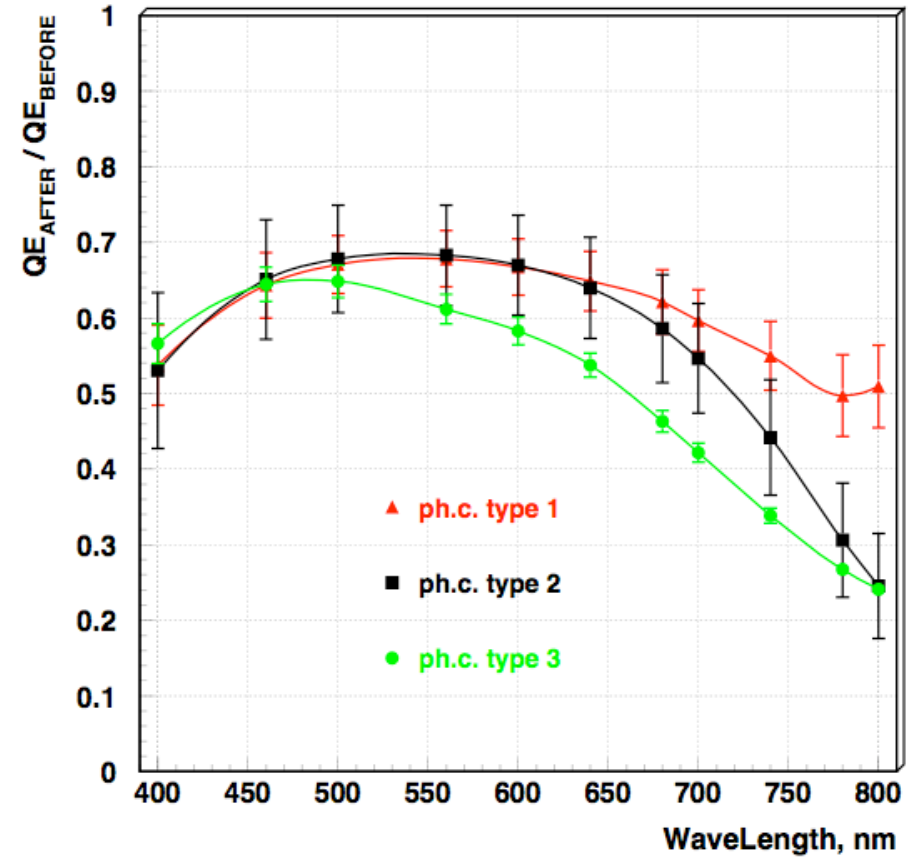
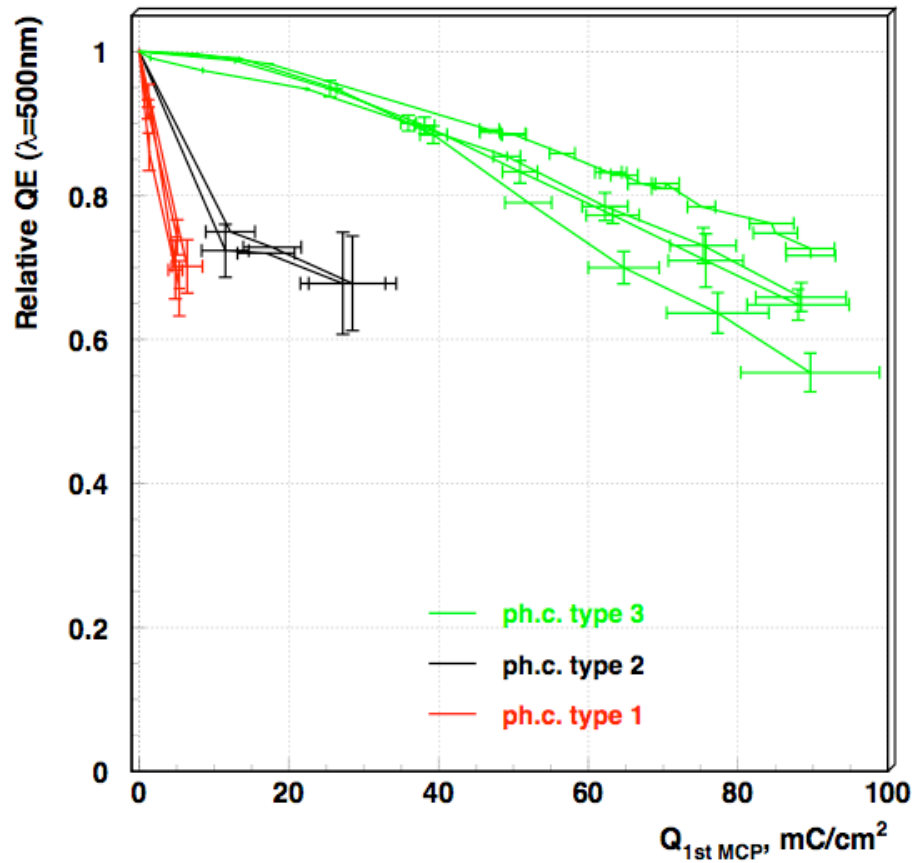


Type 1: $\text{Na}_2\text{KSb}(\text{Cs})$
Dark rate ~ 0.5 kcps/cm²

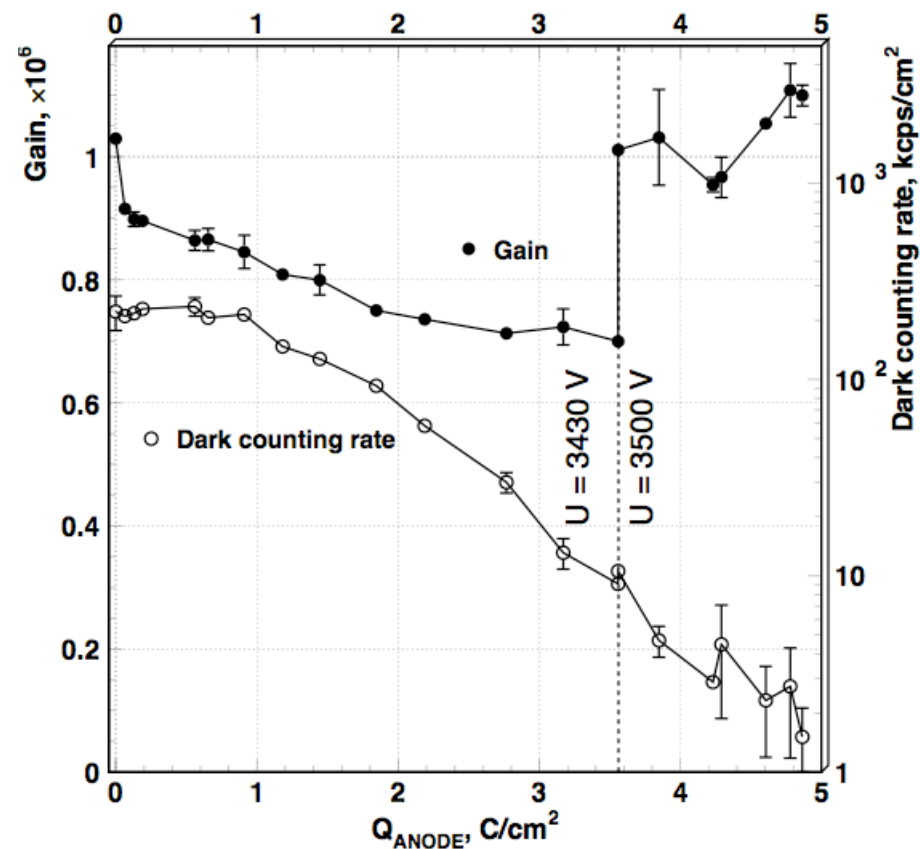
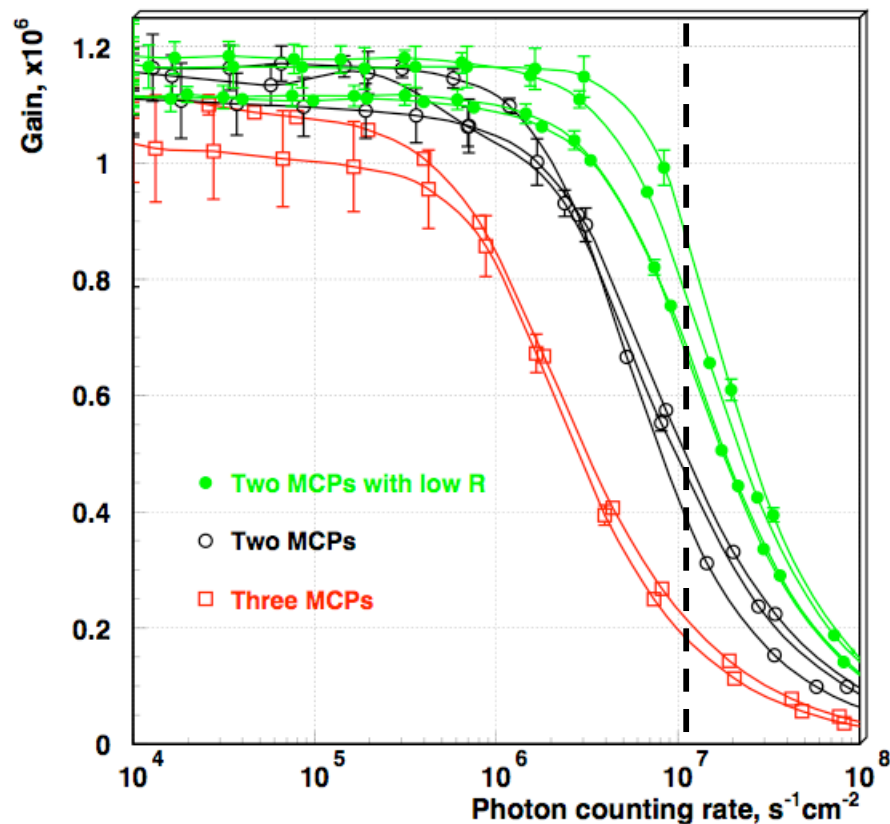
Type 2: $\text{Na}_2\text{KSb}(\text{Cs}) + \text{Cs}$
Dark rate ~ 5 kcps/cm²

Type 3: $\text{Na}_2\text{KSb}(\text{Cs}) + \text{Cs}_3\text{Sb}$
Dark rate $\sim 50\text{-}100$ kcps/cm²

Photocathodes: aging comparison

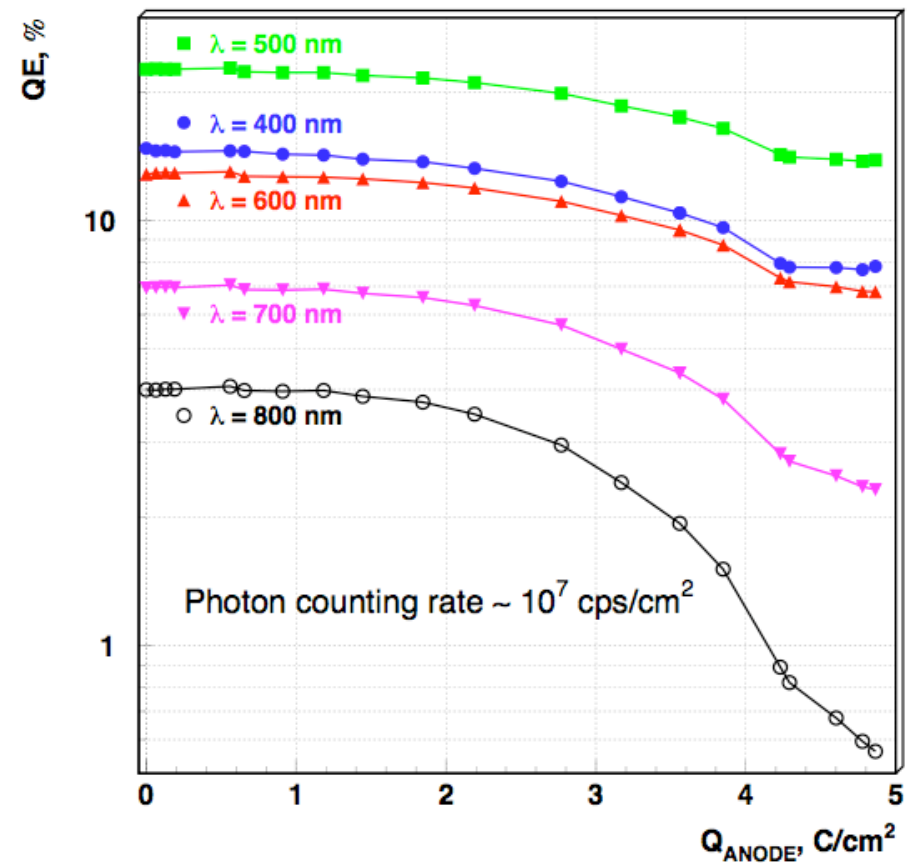
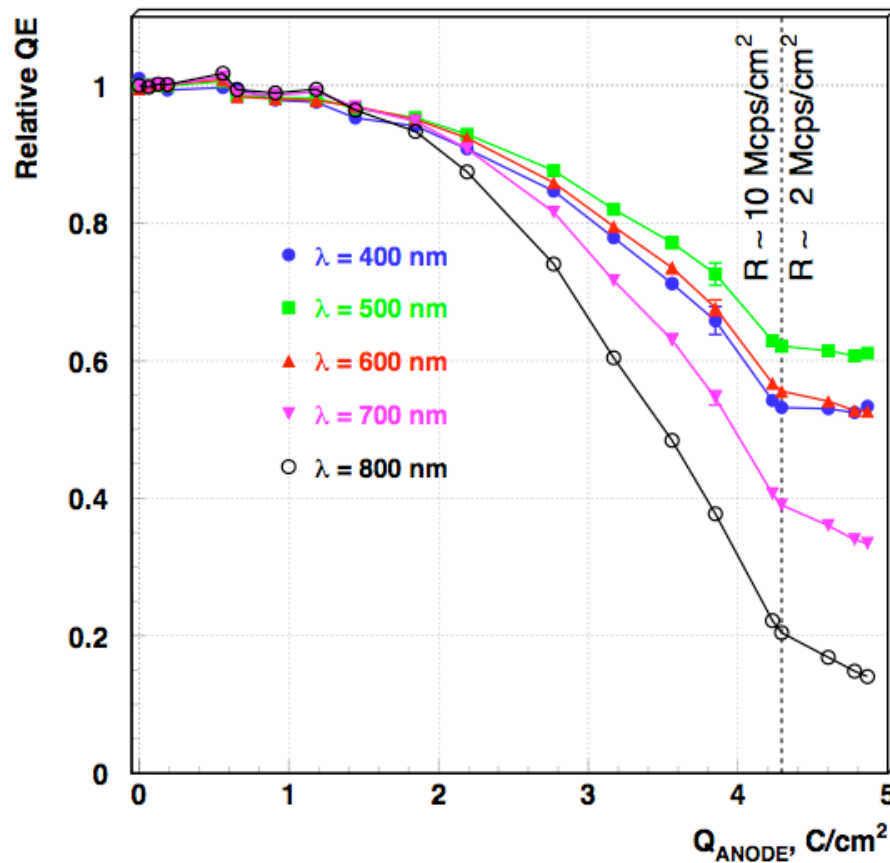


MCP PMT #91110: gain and dark rate



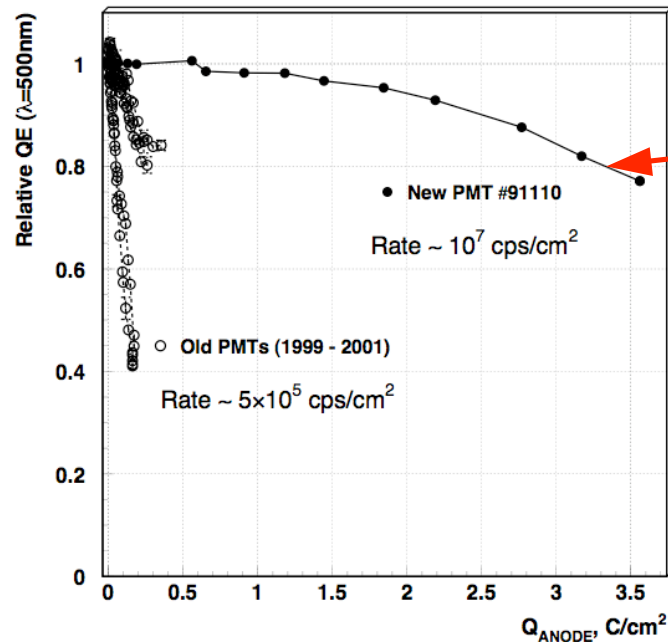
Lifetime measurements at counting rate of $10^7 s^{-1}cm^{-2}$
where gain decreases by 20-30%

MCP PMT #91110: photocathode lifetime



3.3 C/cm^2 of accumulated anode charge
 ↓
 20% degradation of QE(500nm)

MCP PMT lifetime comparison

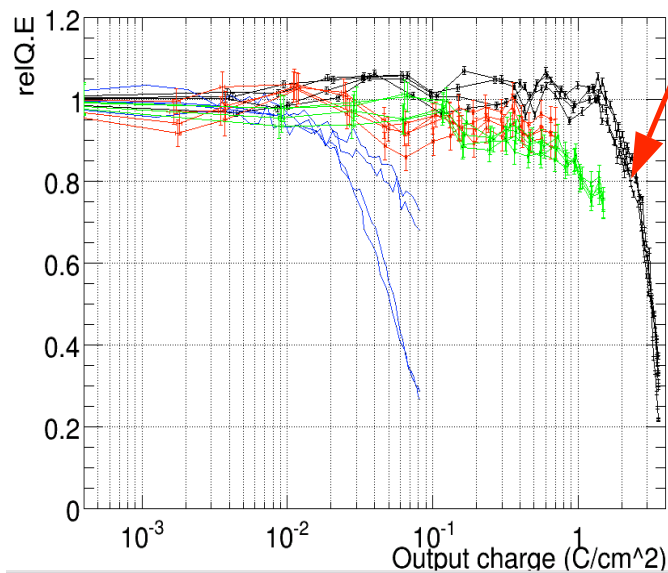


Novosibirsk : 3.0 C/cm² ($R \sim 1 \times 10^7 \text{ s}^{-1}\text{cm}^{-2}$)

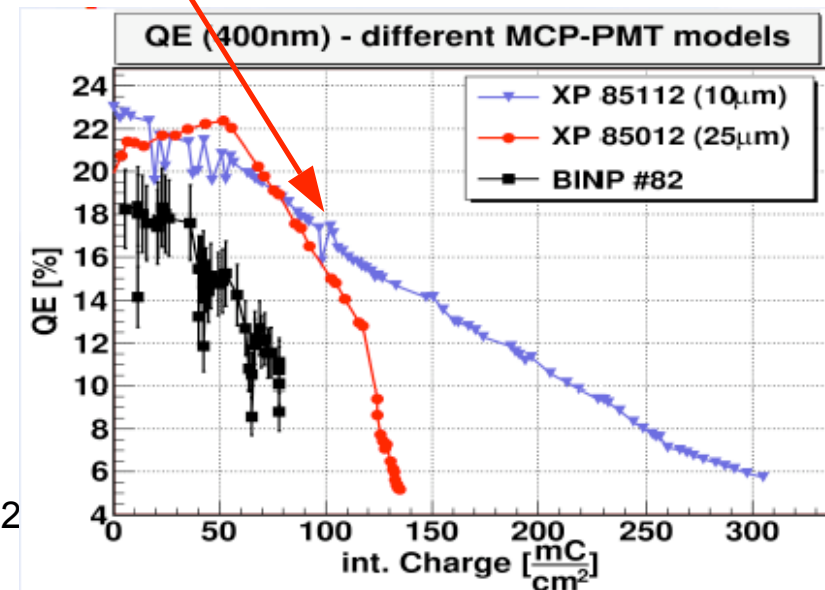
Hamamatsu : 2.5 C/cm² ($R \sim 5 \times 10^5 \text{ s}^{-1}\text{cm}^{-2}$)

Photonis : 0.1 C/cm² ($R \sim 2 \times 10^5 \text{ s}^{-1}\text{cm}^{-2}$)

($G_0 \sim 10^6$)



RC seminar, 2



Summary

- The counting rate capability is determined by MCP strip current and can be increased by decrease of MCP resistivity.
- QE degradation is proportional to the charge extracted from the 1st MCP (at high counting rate).
- Enhancement of MCP electron scrubbing did not affect MCP gain and decreased the photocathode aging rate.
- Optimization of the photocathode formation process can decrease aging rate by order of magnitude.
- The photocathode lifetime of the best MCP PMT sample is more than 3 C/cm² of accumulated anode charge.

Plans

If enough money for R&D are found:

Development of square-shaped multianode MCP PMT

If "Ekran FEP" is interested:

Further enhancement of MCP degassing
BiAlkali photocathode study

Else:

Investigation of the rate capability and
the photocathode aging in magnetic field